

Notice of References Cited	Application/Control No. 10/656,452	Applicant(s)/Patent Under Reexamination ELLSBERRY ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,798,567	08-1998	Kelly et al.	257/723
	B	US-6,597,062	07-2003	Li et al.	257/686
	C	US-6,740,981	05-2004	Hosomi, Eiichi	257/778
	D	US-6,521,984	02-2003	Matsuura, Tetsuya	257/678
	E	US-6,522,022	02-2003	Murayama, Kei	257/786
	F	US-6,538,332	03-2003	Murayama et al.	257/777
	G	US-6,617,695	09-2003	Kasatani, Yasushi	257/778
	H	US-6,137,164	10-2000	Yew et al.	257/686
	I	US-6,239,496	05-2001	Asada, Junichi	257/777
	J	US-6,303,997	10-2001	Lee, Seon Goo	257/778
	K	US-6,504,241	01-2003	Yanagida, Toshiharu	257/686
	L	US-6,437,990	08-2002	Degani et al.	361/783
	M	US-6,448,506	09-2002	Glenn et al.	174/260

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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	U	
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	X	

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,451,624	09-2002	Farnworth et al.	438/106
	B	US-6,462,421	10-2002	Hsu et al.	257/777
	C	US-6,507,107	01-2003	Vaiyapuri, Venkateshwaran	257/723
	D	US-6,274,929	08-2001	Leong et al.	257/724
	E	US-6,025,648	02-2000	Takahashi et al.	257/778
	F	US-6,297,960	10-2001	Moden et al.	361/719
	G	US-5,995,379	11-1999	Kyougoku et al.	361/803
	H	US-5,973,392	10-1999	Senba et al.	257/686
	I	US-5,854,507	12-1998	Miremadi et al.	257/686
	J	US-6,388,333	05-2002	Taniguchi et al.	257/777
	K	US-6,188,127	02-2001	Senba et al.	257/686
	L	US-6,339,254	01-2002	Venkateshwaran et al.	257/686
	M	US-6,525,943	02-2003	Moden et al.	361/719

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,180,881	01-2001	Isaak, Harlan Ruben	174/52.4
	B	US-5,883,426	03-1999	Tokuno et al.	257/686
	C	US-6,717,812	04-2004	Pinjala et al.	361/699
	D	US-6,714,418	03-2004	Frankowsky et al.	361/735
	E	US-6,703,697	03-2004	Leahy et al.	257/678
	F	US-6,531,337	03-2003	Akram et al.	438/108
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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